

## WNM6001

**Single N-Channel, 60V, 0.50A, Power MOSFET**

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

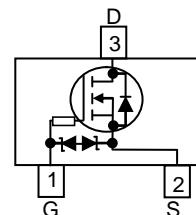
<b>V<sub>DS</sub> (V)</b>	<b>R<sub>DS(on)</sub> (Ω)</b>
60	1.4@ V <sub>GS</sub> =10V
	1.7@ V <sub>GS</sub> =4.5V
ESD Rating:2000V HBM	



## Descriptions

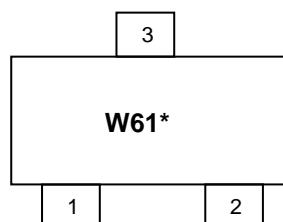
**SOT-23**

The WNM6001 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM6001 is Pb-free and Halogen-free.



## Pin configuration (Top view)

## Features



- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOT-23

W61 = Device Code

\* = Month (A~Z)

## Marking

## Applications

## Order information

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

<b>Device</b>	<b>Package</b>	<b>Shipping</b>
WNM6001-3/TR	SOT-23	3000/Reel&Tape

### Absolute Maximum ratings

Parameter	Symbol	10 s	Steady State	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	±20	V
Gate-Source Voltage	V <sub>GS</sub>	±20		
Continuous Drain Current <sup>ad</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	0.50	0.44
	T <sub>A</sub> =70°C		0.40	0.35
Maximum Power Dissipation <sup>ad</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	0.69	0.53
	T <sub>A</sub> =70°C		0.44	0.34
Continuous Drain Current <sup>bd</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	0.47	0.42
	T <sub>A</sub> =70°C		0.38	0.33
Maximum Power Dissipation <sup>bd</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	0.60	0.47
	T <sub>A</sub> =70°C		0.39	0.30
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>		1.0	A
Operating Junction Temperature	T <sub>J</sub>		-55 to 150	°C
Lead Temperature	T <sub>L</sub>		260	°C
Storage Temperature Range	T <sub>stg</sub>		-55 to 150	°C

### Thermal resistance ratings

Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 10 s	R <sub>θJA</sub>	140	180
	Steady State		176	232
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t ≤ 10 s	R <sub>θJA</sub>	165	205
	Steady State		198	261
Junction-to-Case Thermal Resistance	R <sub>θJC</sub>	100	120	°C/W

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

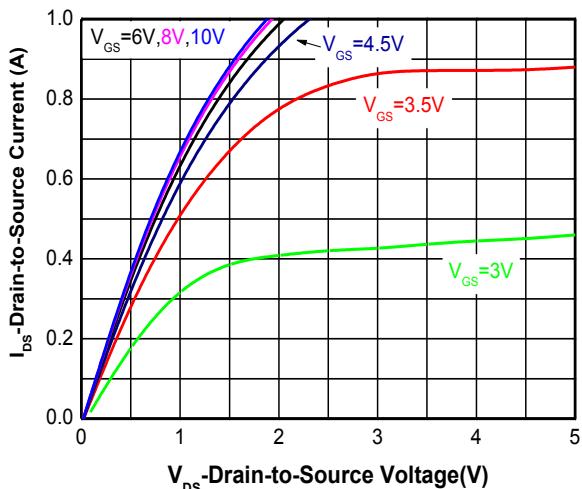
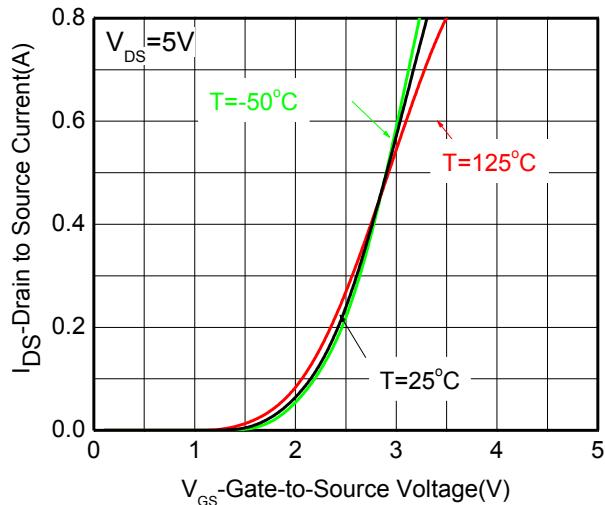
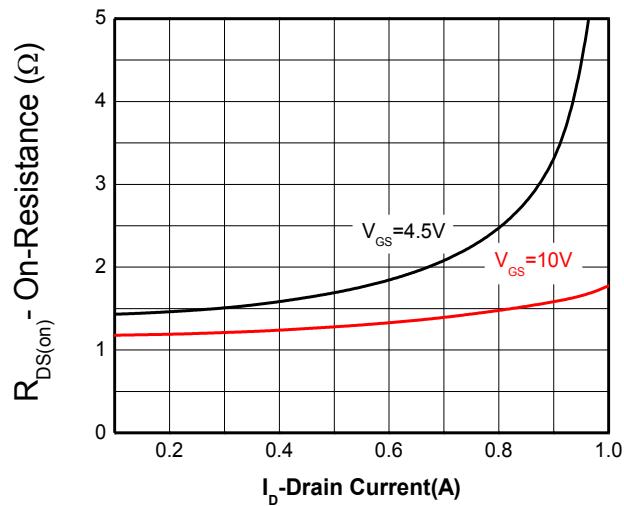
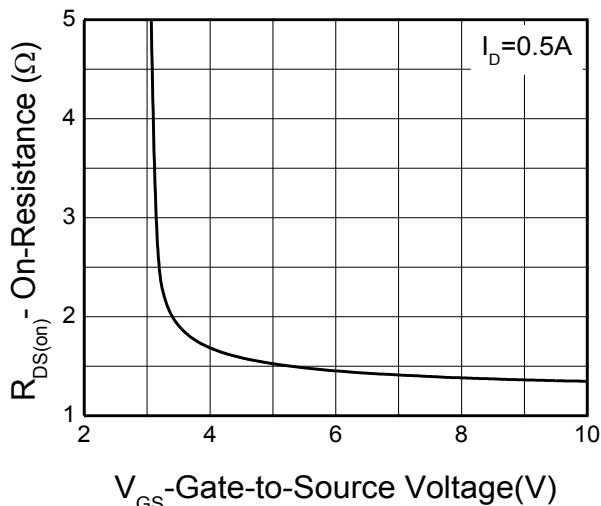
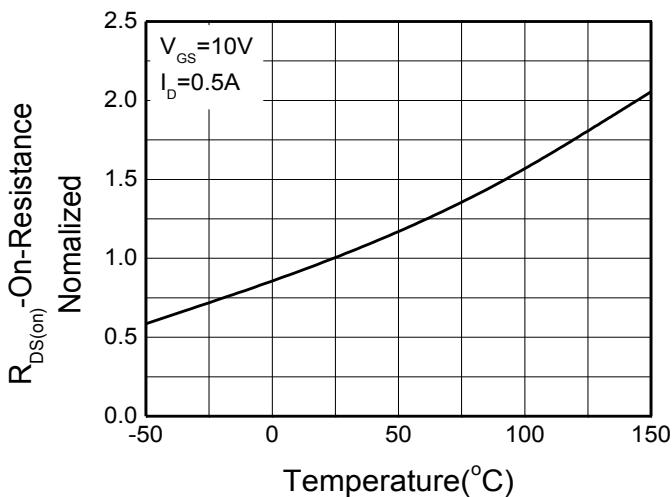
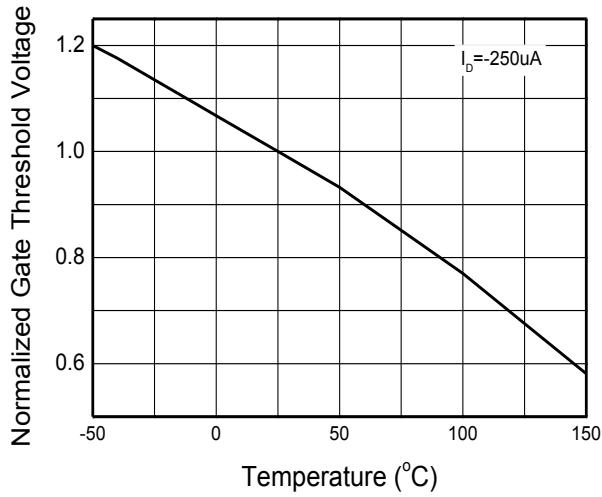
b Surface mounted on FR-4 board using minimum pad size, 1oz copper

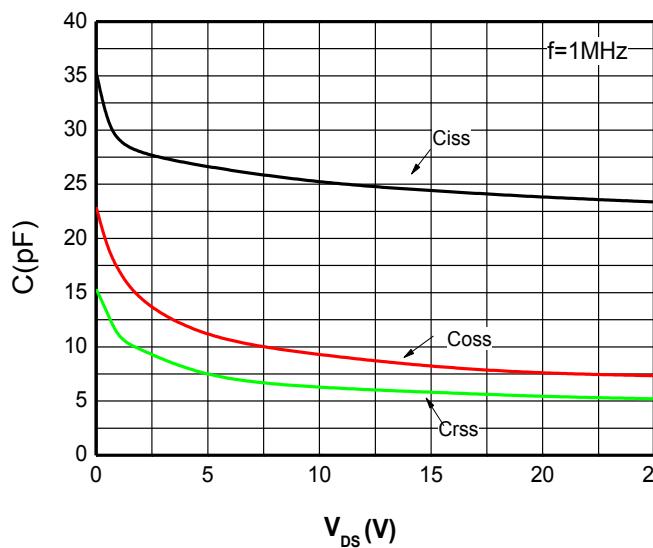
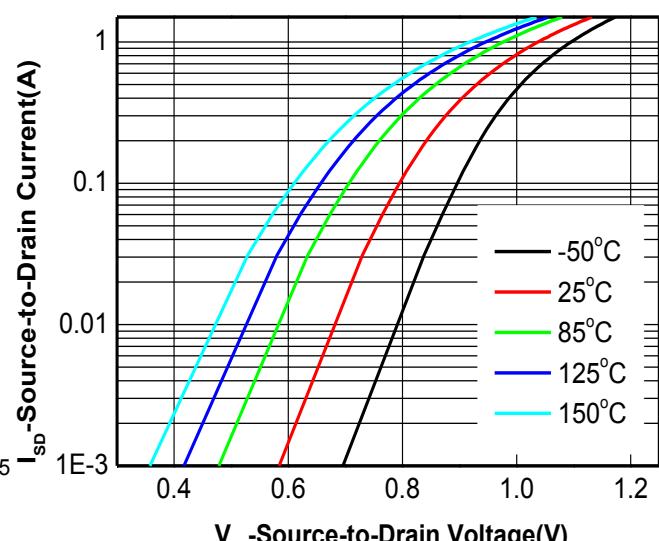
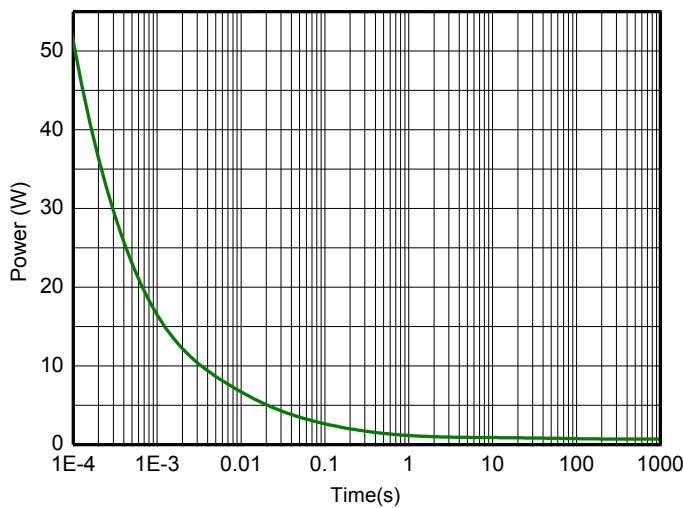
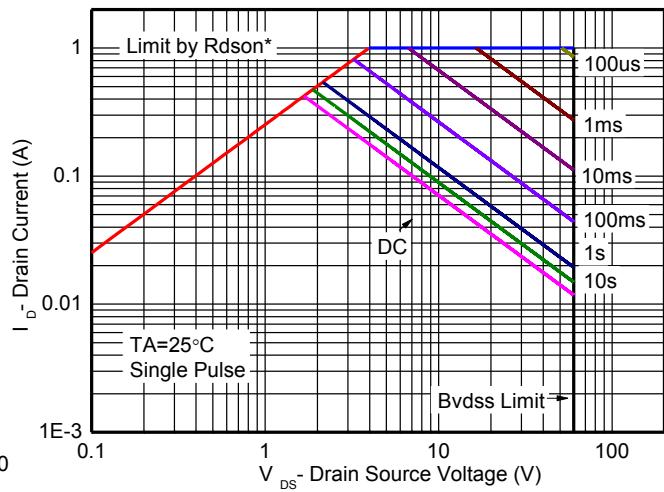
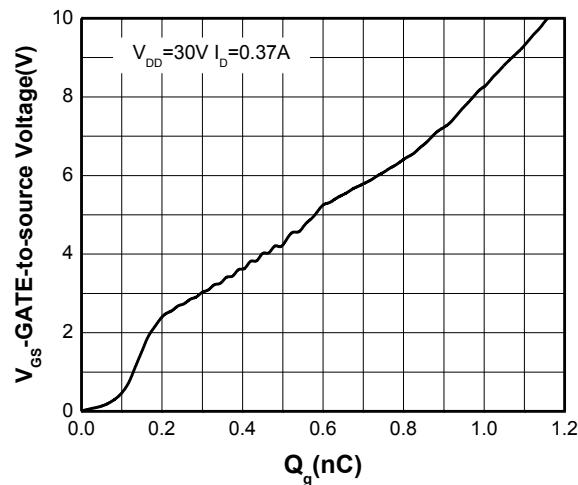
c Pulse width<380μs

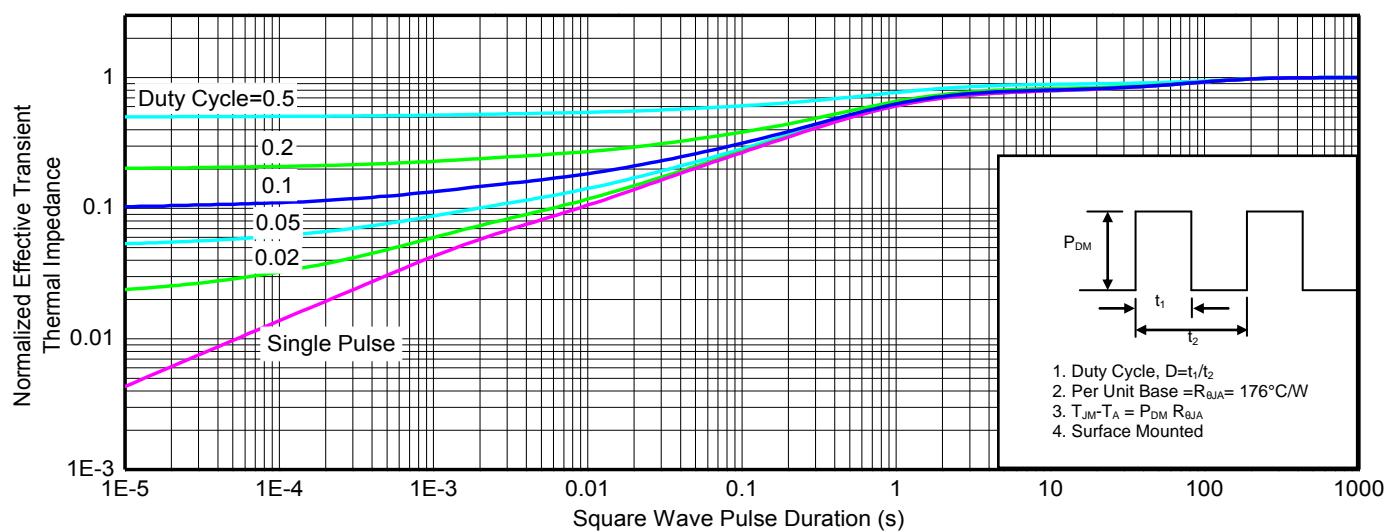
d Maximum junction temperature T<sub>J</sub>=150°C.

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

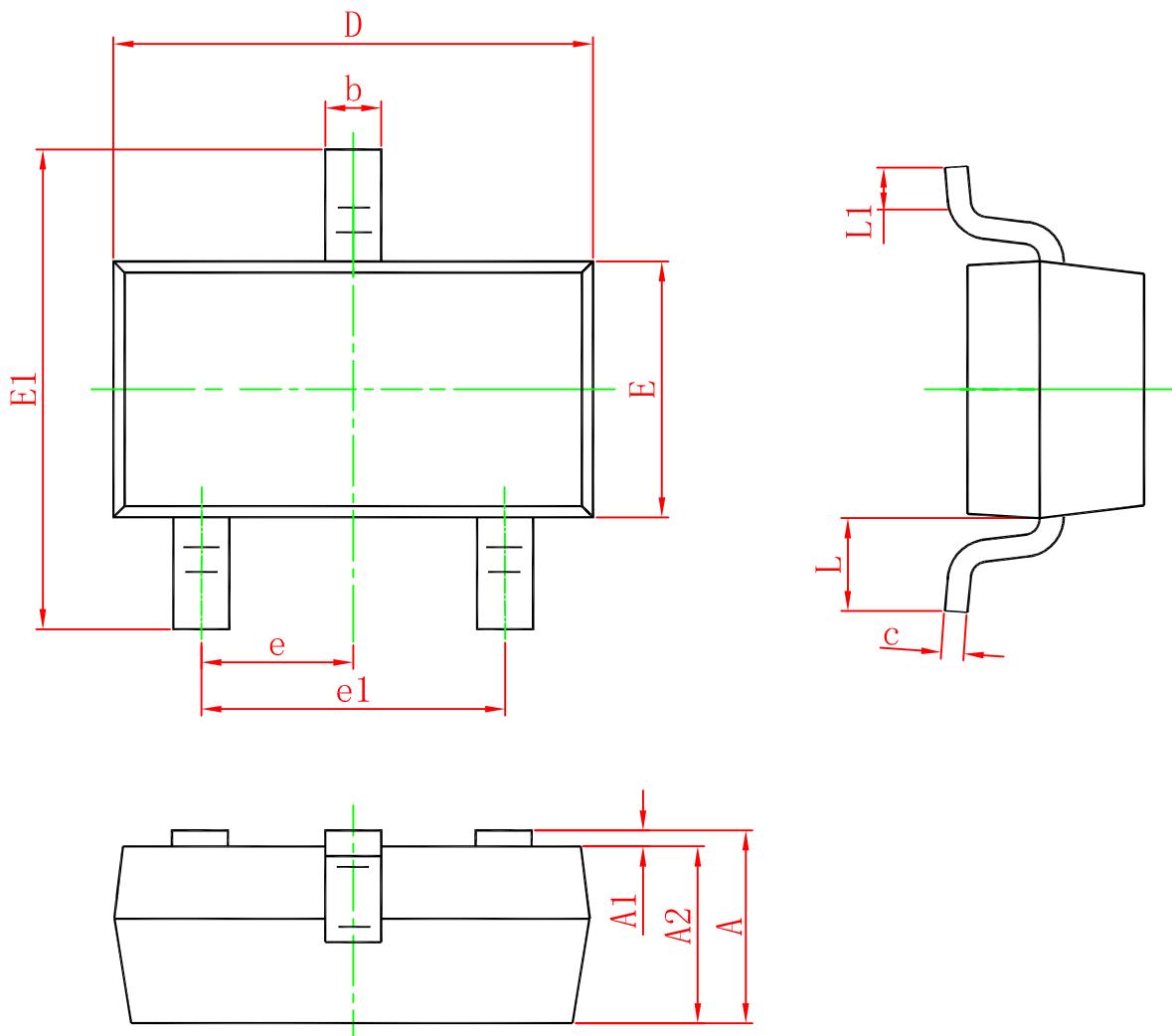
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0 \text{ V}, I_D = 250\mu\text{A}$	60			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 60\text{V}, V_{GS} = 0\text{V}$			1	$\mu\text{A}$
Gate-to-source Leakage Current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20\text{V}$			$\pm 5$	$\mu\text{A}$
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	0.8	1.3	2	V
Drain-to-source On-resistance <sup>b, c</sup>	$R_{DS(on)}$	$V_{GS} = 10\text{V}, I_D = 0.5\text{A}$		1.4	2.0	$\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 0.2\text{A}$		1.7	2.6	
Forward Transconductance	$g_{FS}$	$V_{DS} = 15\text{V}, I_D = 0.25\text{A}$		0.42		S
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz},$ $V_{DS} = 25\text{V}$		23.37		pF
Output Capacitance	$C_{OSS}$			7.33		
Reverse Transfer Capacitance	$C_{RSS}$			5.2		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10 \text{ V},$ $V_{DD} = 30 \text{ V},$ $I_D = 0.37\text{A}$		1.2		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.15		
Gate-to-Source Charge	$Q_{GS}$			0.21		
Gate-to-Drain Charge	$Q_{GD}$			0.12		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$td(\text{ON})$	$V_{DD}=30\text{V}, I_D=0.2\text{A},$ $V_{GEN}=10\text{V}, R_G=10 \Omega$		7.6		ns
Rise Time	$tr$			5.1		
Turn-Off Delay Time	$td(\text{OFF})$			24.6		
Fall Time	$tf$			10		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_S = 0.3\text{A}$		0.9	1.5	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-Source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**


**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Transient thermal response (Junction-to-Ambient)**

**Package outline dimensions**
**SOT-23**


Symbol	Dimensions in millimeter	
	Min.	Max.
A	0.890	1.200
A1	0.013	0.100
b	0.370	0.510
c	0.080	0.190
D	2.800	3.040
E	1.200	1.400
E1	2.200	2.600
e	0.890	1.020
e1	1.780	2.040
L1	0.2 MIN.	